## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/811,919	Reexamination IIDA, NOBUYUKI	
Examiner	Art Unit	
SAEID EBRAHIMI DEHKORDY	2625	Page 1 of 1

## U.S. PATENT DOCUMENTS

	U.S. I ATENT DOGGMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0137577	07-2003	Shinohara, Tadashi	347/134
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	T	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
Γ	v	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.